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Unravelling Heterodyne Force Microscopy

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Unravelling Heterodyne Force Microscopy



Cover illustration: Artist impression of the most important experiment described in this thesis; the surface image are the real data that we obtained during the measurement on a well-defined sample: A planar ultrasonic wave is sent from the bottom into a polymer sample, which contains spherical gold nanoparticles. These nanoparticles dissipate a significant amount of energy due to a process, which we called friction at shaking nanoparticles. This leads to a reduction in the amplitude of the ultrasonic wave. We detect this reduction in amplitude as “black dots” on the surface with the cantilever in an Atomic Force Microscope (for details see Chap. 6).

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Unravelling Heterodyne Force Microscopy

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aan Nicole, aan mijn ouders

Contents

Introduction and Outline	1
1 General and Experimental Background	7
1.1 Atomic Force Microscope	8
1.2 Heterodyne Force Microscope	9
1.3 Development of our HFM	12
1.3.1 Home-Built Cantilever Holder	13
1.3.2 Ultrasonic Sample and Cantilever Excitation	18
1.4 Different Models for the Tip-Sample Interaction	20
2 Ultrasonic Rayleigh Scattering by Subsurface Nanoparticles	25
2.1 Introduction	26
2.2 General Considerations and Definitions	27
2.3 Analytical Calculation	30
2.4 Finite Element Analysis (FEA)	32
2.5 Results and Discussion	36
2.6 Comparison with Experiments	41
2.7 Conclusion	42
Appendices	43
2.A Calculation of the Effective Amplitude A_{eff}	43
2.B Expansion of C_A and C_ϕ	45
2.C Depth Dependence of C_A and C_ϕ in FEA	45
3 Cantilever Dynamics in Heterodyne Force Microscopy	47
3.1 Introduction	48
3.2 Theory and Calculation	50
3.3 Results and Discussion	54
3.4 Conclusion	64
4 Subsurface-AFM: Sensitivity to the Heterodyne Signal	67
4.1 Introduction	68
4.2 Numerical Calculation of the Heterodyne Signal	69
4.3 Experimental Detection of the Heterodyne Signal	74
4.4 Conclusion	78
Appendices	78
4.A Estimation of the Quality Factor Reduction	79

5 Beating beats Nonlinear Mixing in Heterodyne Force Microscopy	81
5.1 Introduction	82
5.2 Beating and Nonlinear Mixing	82
5.3 Results and Discussion	85
Appendices	89
5.A Analytical Derivation of the Difference Frequency Generation	90
5.A.1 Difference Frequency Generation Considering Nonlinear Mixing only	90
5.A.2 Difference Frequency Generation Considering Beating and Mixing	93
5.A.3 Difference Frequency Generation without Feedback to the Input Signal	98
5.B Transfer Function of the Cantilever at the Difference Frequency	99
5.C Resonance Frequency Shifts of the Canitlever Modes	103
5.D Characterizing the Tip-Sample Interaction	103
5.E Experimental Details and the Ultrasonic Amplitudes	105
6 Contrast Mechanism in Heterodyne Force Microscopy: Friction at Shaking Nanoparticles	107
6.1 Introduction	108
6.2 Detection of Deeply Buried Gold Nanoparticles	109
6.3 Subsurface Contrast due to Variations in the Interaction	113
6.4 Friction at Shaking Nanoparticles	118
6.5 Conclusions	120
Appendices	122
6.A Sample Preparation	122
6.B Independent Verification of the Nanoparticle Depth	125
6.C Cross Sections of the HFM Images at a Gold Nanoparticle	127
6.D Experimental Dependence of A_{diff} on the Sample Elasticity	130
6.E Analytical Dependence of A_{diff} on the Sample Elasticity	132
6.F Effective Sample Elasticity above the Nanoparticles	134
6.G Setting up the Numerical Calculations	136
6.H Complete Overview of the Results of the Numerical Calculations	139
6.I Frequency Shifts and their Consequences for the Contrasts	143
References	147
Summary	151
Samenvatting	157
Nawoord	161
Curriculum vitae	162
List of Publications	165